

<b>Issue Classification</b>			Application/Control No.		Applicant(s)/Patent under Reexamination	
			10/786,376		YANG ET AL.	
			Examiner		Art Unit	
			Jia W. Lu		2634	

ORIGINAL				CROSS REFERENCE(S)									
CLASS	SUBCLASS	CLASS	SUBCLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)									
375	319	375	340	324									
INTERNATIONAL CLASSIFICATION													
H	0	4	L	25/6									
H	0	4	L	25/10									
				/									
				/									
				/									
Jia Lu <span style="float: right;">9/15/05</span> (Assistant Examiner) (Date)				 STEPHEN CHIN <span style="float: right;">9/15/05</span> SUPERVISORY PATENT EXAMINEE TECHNOLOGY CENTER 2000 (Primary Examiner) (Date)								Total Claims Allowed: 23	
 Lashawn Marks <span style="float: right;">9/20/05</span> (Legal Instruments Examiner) (Date)												O.G. Print Claim(s)	O.G. Print Fig

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1		31		61		91	
2		32		62		92	
3		33		63		93	
4		34		64		94	
5		35		65		95	
6		36		66		96	
7		37		67		97	
8		38		68		98	
9		39		69		99	
10		40		70		100	
11		41		71		101	
12		42		72		102	
13		43		73		103	
14		44		74		104	
15		45		75		105	
16		46		76		106	
17		47		77		107	
18		48		78		108	
19		49		79		109	
20		50		80		110	
21		51		81		111	
22		52		82		112	
23		53		83		113	
24		54		84		114	
25		55		85		115	
26		56		86		116	
27		57		87		117	
28		58		88		118	
29		59		89		119	
30		60		90		120	